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Key indicators

Single-crystal X-ray study $T=291~\mathrm{K}$ Mean $\sigma(\mathrm{C-C})=0.006~\mathrm{\mathring{A}}$ R factor = 0.042 wR factor = 0.110 Data-to-parameter ratio = 13.4

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

Ammine[2-hydroxy-1-naphthaldehyde 4-piperidylthiosemicarbazonato]nickel(II)

In the title compound, $[Ni(C_{17}H_{17}N_3OS)(NH_3)]$, the Ni atom is in a distorted square-planar geometry, with the 2-hydroxy-1-naphthaldehyde 4-piperidylthiosemicarbazonate ligand coordinated in a terdentate manner through the S, N and O atoms. A molecule of ammonia completes the coordination.

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Comment

The Ni atom in the title compound, (I), exhibits a coordination of four. The 2-hydroxy-1-naphthaldehyde number 4-piperidylthiosemicarbazonate ligand has a charge of 2- and acts as a terdentate ligand, coordinating to the Ni^{II} ion via the thiolate S, the azomethine N and the naphthoxy O atom. The ammonia molecule coordinates in the fourth position. The coordination geometry is distorted square planar, as indicated by the distances and angles around the metal ion. The coordinated thiosemicarbazone ligand is almost planar and the angle between the Ni1-S1-N1-N2-C12 and Ni1-O1-N1-C1-C2-C11 chelate rings is 3.9 (1)°. The angle between the Ni1-S1-N1-N2-C12 chelate ring and the mean plane of the naphthalene rings is 9.4 (1)°. The piperidyl ring is in a chair conformation. A pair of intermolecular N-H···O hydrogen bonds (see Table 2), involving the ammonia H4B atom and the O atom of the coordinated thiosemicarbazone ligand, link molecules into centrosymmetric dimers.

Experimental

4-Piperidylthiosemicarbazide was prepared following a reported procedure (Scovill, 1991). The ligand 2-hydroxy-1-naphthaldehyde 4-piperidylthiosemicarbazone (L) was obtained from a 1:1 molar ratio of 2-hydroxy-1-naphthaldehyde (Aldrich) and 4-piperidylthiosemicarbazide in boiling ethanol containing 2–3 drops of concentrated $\rm H_2SO_4$. Compound (I) was prepared from L and nickel(II) nitrate hexahydrate (Aldrich) in a 1:1 molar ratio in a boiling methanol–ammonia solution. Crystals of (I) were obtained by slow evaporation, at room temperature, of the reaction mixture.

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Crystal data

$[Ni(C_{17}H_{17}N_3OS)(NH_3)]$	Z = 2
$M_r = 387.14$	$D_x = 1.506 \text{ Mg m}^{-3}$
Triclinic, $P\overline{1}$	Mo $K\alpha$ radiation
a = 9.424 (1) Å	Cell parameters from 39
b = 9.482 (1) Å	reflections
c = 9.668 (1) Å	$\theta = 2.9 - 12.5^{\circ}$
$\alpha = 97.08 (1)^{\circ}$	$\mu = 1.27 \text{ mm}^{-1}$
$\beta = 93.70 \ (1)^{\circ}$	T = 291 (2) K
$\gamma = 93.36 \ (1)^{\circ}$	Plate, red
$V = 853.61 (16) \text{ Å}^3$	$0.46 \times 0.16 \times 0.08 \text{ mm}$

Data collection

Siemens P4/PC diffractometer	2435 reflections with $I > 2\sigma(I)$
Siemens F4/FC unitractometer	
ω scans	$R_{\rm int} = 0.046$
Absorption correction: analytical	$\theta_{\rm max} = 25.0^{\circ}$
based on measured indexed	$h = 0 \rightarrow 11$
crystal faces (SHELXTL;	$k = -11 \rightarrow 11$
Sheldrick, 1997b)	$l = -11 \rightarrow 11$
$T_{\min} = 0.770, T_{\max} = 0.915$	3 standard reflections
3219 measured reflections	every 97 reflections
3018 independent reflections	intensity decay: <2%
D.C.	

Refinement

Refinement on F^2	$w = 1/[\sigma^2(F_o^2) + (0.05)]$
$R[F^2 > 2\sigma(F^2)] = 0.042$	+ 0.0722P]
$wR(F^2) = 0.110$	where $P = (F_o^2 + 2$
S = 1.00	$(\Delta/\sigma)_{\rm max} = 0.013$
3018 reflections	$\Delta \rho_{\text{max}} = 0.43 \text{ e Å}^{-3}$
226 parameters	$\Delta \rho_{\min} = -0.49 \text{ e Å}^{-3}$
H atoms treated by a mixture of	
independent and constrained	
refinement	

 $w = 1/[\sigma^2(F_o^2) + (0.0584P)^2]$ + 0.0722P $(1/\sigma)_{\rm max} = 0.013$ $o_{\text{max}} = 0.43 \text{ e Å}^{-3}$

Table 1 Selected geometric parameters (Å, °).

Ni1-N1	1.841 (3)	O1-C2	1.310 (5)
Ni1-O1	1.858 (3)	N1-C11	1.305 (4)
Ni1-N4	1.926(3)	N1-N2	1.397 (4)
Ni1-S1	2.1465 (11)	N2-C12	1.303 (5)
S1-C12	1.758 (3)	N3-C12	1.365 (4)
N1-Ni1-O1	95.21 (12)	N1-Ni1-S1	87.48 (9)
N1-Ni1-N4	177.42 (16)	O1-Ni1-S1	177.17 (9)
O1-Ni1-N4	84.65 (15)	N4-Ni1-S1	92.62 (13)

Table 2 Hydrogen-bonding geometry (Å, °).

$D-H\cdots A$	D-H	$H \cdot \cdot \cdot A$	$D \cdot \cdot \cdot A$	$D-\mathrm{H}\cdots A$
N4-H4 <i>B</i> ···O1 ⁱ	0.91 (5)	2.19 (6)	3.088 (4)	170 (5)

Symmetry code: (i) -x, 1 - y, -z.

The ammonia H atoms were found in a difference Fourier map and were refined isotropically. The refined N-H distances range from 0.84 (6) to 1.01 (5) Å. H atoms attached to C atoms were included in

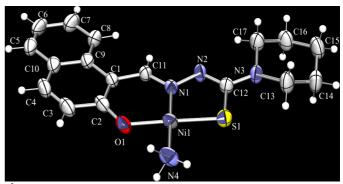


Figure 1 The molecular structure of (I). Displacement ellipsoids are drawn at the 30% probability level.

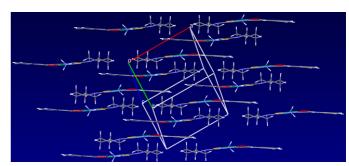


Figure 2 The crystal packing of (I).

calculated positions (C-H 0.93-0.97 Å), and refined using a riding model, with fixed displacement parameters ($U_{\rm iso} = 1.2 U_{\rm eq}$ of the atom to which they are bonded).

Data collection: XSCANS (Siemens, 1994); cell refinement: XSCANS; data reduction: XSCANS; program(s) used to solve structure: SHELXTL/PC (Sheldrick 1997b); program(s) used to refine structure: SHELXL97 (Sheldrick, 1997a); molecular graphics: PLATON (Spek, 1999) and MERCURY (Bruno et al., 2002); software used to prepare material for publication: SHELXL97 and PLATON.

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